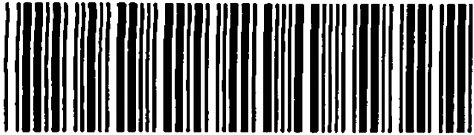


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/015,677	BAUDISCH ET AL.	
	Examiner	Art Unit	
	VIJAY SHANKAR	2629	

SEARCHED			
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345	1.1-3.4,	11/25/2007	VS
345	691-709		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Interference Search History Printout (US-PGPUB)		11/25/2007	VS

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Interference Search History Printout (US-PGPUB)	11/25/2007	VS